



USB Type-C 10Gbps Bi-directional Retimer with Adaptive Equalizer, Low-latency with 1.8V Single Power Supply

Features

- · Compliant for USB 10Gbps and 5Gbps Standards
- Support Dual-port USB Jitter cleaning
- -23dB at 5GHz channel loss compensation
- Low Latency < 1ns.
- Adaptive Continuous Time Linear Equalizer (CTLE)
- No reference clock design.
- Rx termination detection for power saving control
- Selectable adjustment of 3-taps transmitter.
- Single power supply of 1.8 ± 90 mV.
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- For automotive applications requiring specific change control (i.e. parts qualified to AEC-Q100/101/104/200, PPAP capable, and manufactured in IATF 16949 certified facilities), please contact us or your local Diodes representative. https://www.diodes.com/guality/product-definitions/

Description

The DIODES[™] PI2EQX22024 is a bit level ReTimer with receiver adaptive CTLE and transmitter 3-tap equalization which can compensate channel loss up to -23dB for 5GHz signal transmission. It supports USB3.2 standards for USB Type-C[®] data mode operation. The operation configurations are programmable via I2C interface to select 1 lane USB3.2 Gen1x1/Gen2x1, 1/2 lane USB3.2 Gen1x1/ Gen2x1 or USB3.2 Gen2x2.

To achieve good power saving management, this device uses the common 1.8v Vdd power supply. It complies with USB link power management states for active mode (U0) and power saving mode (U1, U2, U3). USB Rx detection monitors the plug condition of the TX terminals continuously. The LFPS signal detector detects the LBPM (LFPS Based PWM Message) of USB mode.

With the merit of the bit level ReTimer design, PI2EQX22024 has very low latency from signal input to output (< 1ns) that serves good interoperability among various USB devices.

Application(s)

- Source Devices : Tablets, Smart Phone, Notebook, Desktop, All-In-One PCs
- Sink Devices : Monitors, TVs
- PC Docking, Active Cables, Dongles (Adapters)

Ordering Information

Ordering Number	Package Code	Package Description
PI2EQX22024XEAEX	XEA	32-pin, X1-QFN2845-32 (2.85x4.5mm), 0.4mm pitch, 0.45mm height

Notes:

• E = Pb-free and Green

X suffix = Tape/Reel

Notes:

^{1.} No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

^{2.} See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free. 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds

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2. General Information



Figure 2-1 The Channel Configuration Against the OP_MODE<3:0>





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Pin Configuration 3.



Figure 3-1 PI2EQX22024 Pin Configuration





3.1 Pin Description

Pin #	Pin Name	Туре	Description	
Power and GND				
6, 19, 25	VDD1P8	Power	1.8V power supply, +/- 5%	
12, 13, 14, 15, 16, 22, 30, Center Pad	GND	GND	Supply Ground	
3	CAP_CON2	Power	The CON2 VDD1V external decoupling capacitor.	
9	CAP_CON1	Power	The CON1 VDD1V external decoupling capacitor.	
Control Pins				
32	EN	Ι	Chip Enable. With internal 340kΩ pull-up resistor. "Low": Chip Power Down "High": Normal Operation (Default)	
28	SCL_3P3	Ι	SCL is I2C control bus clock. Open drain structure (3.3V tolerance)	
29	SDA_3P3	I/O	SDA is I2C control bus data. Open drain structure. (3.3V tolerance)	
31	A0	Ι	2-level I2C address selection pins. With internal 340k Ω pull-down resistor.	
High Speed I/O Pins				
1, 2 24, 23 8, 7 17, 18	AP_RX2P/N, CON_RX2P/N AP_RX1P/N, CON_RX1P/N	Ι	RX CML input terminals. Input with termination 50 Ω to GND or 75k Ω to GND.	
27, 26 4, 5 20, 21 11, 10	CON_TX2P/N, AP_TX2P/N CON_TX1P/N, AP_TX1P/N	О	TX CML output terminals. Output termination 50/1.5k Ω to VbiasTX, 3k Ω to GND or 75k Ω to GND.	





4. Functional Description

4.1 Detail Features

USB Type-C 10Gbps Mode

- Maximum channel loss compensation up to -23dB at 5GHz
- Bit-level USB Retimer for low latency
- Adaptive receiver Continuous Time Linear Equalizer (CTLE)
- No reference clock design
- I2C slave to configure the channel setting and operation mode
- USB standard mode support: USB 1-lane only, USB 2-lane for type A and USB Gen 2x2 normal/flip modes

USB Channels

- USB3.2 Gen1x1, Gen2x1 and Gen2x2 Retiming mode
- Bit-level USB Retimer

Tx/Rx IO Channels

- Rx termination detection for power saving control
- RX termination: 50Ω to GND or $75k\Omega$ to GND
- TX driver output termination: $50/1.5k\Omega$ to VbiasTx, $3k/75k\Omega$ to GND.
- Selectable adjustment of 3-taps transmitter.

Power

- Single power supply of 1.8±90mV
- 650mW active power consumption for 2-ch USB 10Gbps operating mode
- <500uW target in power down mode



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4.2 Functional Block Diagram

Below is shown the simple bi-directional re-timer. The RX termination resistor is terminated to GND and TX termination resistor is terminated to VbiasTX. The TX driver is a 3-taps Feed Forward Equalization (FFE) driver with programmable tuning coefficient to meet multiple standards. The Continuous-Time-Linear Equalizer (CTLE) is adaptive and controlled by the digital state machine after the training.

The signal detector is used to decode the LBPM (LFPS Based PWM Message) and control the power status.



Figure 4-1 PI2EQX22024 Bi-directional Retimer Block Diagram



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Figure 4-2 PI2EQX22024 Functional Retimer Block Diagram





4.3 USB Mode

To be able to enhanced the re-timer's power efficiency, the supported power state in USB SSP is following: U0 and non-U0s (RXDET/ U1/U2/U3).

The I/O termination resistance under different conditions

Symbol	Parameter	Resistance	Units
RX terminal			
Rin-pd	Input resistance at power down mode	75k to GND	Ω
Rin-U0	Input resistance at U0 condition	50 to GND	Ω
Rin-U1	Input resistance inU1 ⁽¹⁾	50 to GND	Ω
Rin-U2/U3	Input resistance in U2/U3 ⁽¹⁾	50 to GND	Ω
Rin-RXDet	Input resistance in RXDET ⁽¹⁾	75k to GND	Ω
TX terminal			
Rout-pd	Output resistance at power down mode	75k to GND	Ω
Rout-U0	Output resistance at U0 condition	50 to VbiasTx	Ω
Rout-U1	Output resistance in U1 mode (1)	1.5k to VbiasTx	Ω
Rout-U2/U3	Output resistance in U2/U3 mode ⁽¹⁾	3k to GND	Ω
Rout-RXDet	Output resistance in RXDET mode (1)	3k to GND	Ω

Notes: (1) The value of Rin-RxDet will be updated only after the receiver evaluation has been done. Thus, the value can be 50Ω or $75k\Omega$ to GND.



Figure 4-3 Re-timer Supported USB Power State Diagram





4.4 I2C Programming

4.4.1 I2C Address

		Register Bits						
	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
Slave address	1	0	1	0	0	0	A0	0/1 (W/R)

4.4.2 I2C Operation

- I2C interface operates as a slave device.
- The device supports Indexed read/write
- Support operating speed up to 1MHz
- Supported 7-bit addressing •
- The data byte format is 8-bit bytes with the most significant bit (MSB) first.
- Will never hold the clock line SCL LOW to force the master into a wait state. •
- No response when the data on common bus is matched to the device address.
- If I2C master want read/write invalid register, i.e. the I2C slave just write/read from a dummy RO register with FF by default.

4.4.3 Acknowledge

Data transfer with acknowledge is required from the master. When the master releases the SDA line (HIGH) during the acknowledge clock pulse, it will pull down the SDA line during the acknowledge clock pulse so that it remains stable LOW during the HIGH period of this clock pulse as indicated in the I2C Data Transfer diagram. It will generate an acknowledge after each byte has been received.

4.4.4 Data Transfer

A data transfer cycle begins with the master issuing a start bit. After recognizing a start bit, it will watch the next byte of information for a match with its address setting. When a match is found it will respond with a read or write of data on the following clocks. Each byte must be followed by an acknowledge bit, except for the last byte of a read cycle which ends with a stop bit. Data is transferred with the most significant bit (MSB) first. It will never hold the clock line SCL LOW to force the master into a wait state.

4.4.5 Start & Stop Condition

A HIGH to LOW transition on the SDA line while SCL is HIGH indicates a START condition. A LOW to HIGH transition on the SDA line while SCL is HIGH defines a STOP condition, as shown in the figure below



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Figure 4-4 I2C Start and STOP Condition



Figure 4-5 Indexed Read Protocol



Figure 4-6 Indexed Write Protocol



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4.5 Register Assignment

Byte 0	Byte 0 (Vendor ID Register)				
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0			
6	RO	0	Revision ID	Devision ID 0010	
5	RO	1		Revision $ID = 0010$	
4	RO	0			
3	RO	0			
2	RO	0	Van dan ID	Devicement ID 0011	
1	RO	1		Pericom ID = 0011	
0	RO	1			
Byte 1 ((Device Typ	pe/Device ID registe	r)		
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0			
6	RO	0	Device Type	Device Type 0010 = Retimer	
5	RO	1			
4	RO	0			
3	RO	0		Device ID =0001	
2	RO	0	Davica ID		
1	RO	0	Device ID		
0	RO	1			
Byte 2 ((Byte count	t Register)			
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	1			
6	RO	0			
5	RO	0			
4	RO	0	Degister Pute count	12C byte count = 120 bytes	
3	RO	0	Register Dyte count	120 byte count = 120 bytes	
2	RO	0			
1	RO	0			
0	RO	0			





Byte 3 (Byte 3 (Channel assignment)					
Bit	Туре	Power up condition	Purpose	Comment		
7	R/W	0	OP_MODE<3>			
6	R/W	0	OP_MODE<2>	Colored the Application Made		
5	R/W	0	OP_MODE<1>	Selects the Application Mode		
4	R/W	0	OP_MODE<0>			
3	R/W	0	Reserved			
2	R/W	0	Reserved			
1	R/W	0	Reserved			
0	R/W	0	Reserved			
Byte 4 ((Override t	he power down con	trol)			
Bit	Туре	Power up condition	Purpose	Comment		
7	R/W	0	PD_CON_TX2			
6	R/W	0	PD_CON_RX2	CONx power down override		
5	R/W	0	PD_CON_TX1	1 – Force the CONx to power down state		
4	R/W	0	PD_CON_RX1			
3	R/W	1	Reserved			
2	R/W	0	Reserved			
1	R/W	0	Reserved			
0	R/W	0	Reserved			
Byte 5 ((Reserved)					
Byte 6	(CON2 US	B mode Pre-shot an	d De-emphasis setting)			
Bit	Туре	Power up condition	Purpose	Comment		
7	R/W	0	CON_TX2_USB_GEN2_SW_PE_ DE<1>	USB mode CON2:		
6	R/W	0	CON_TX2_USB_GEN2_SW_PE_ DE<0>	USB Gen2 Pre-shot and De-emphasis setting USB_GEN2_SW_PE_DE<1:0>		
5	R/W	0	CON_RX2_USB_GEN2_SW_PE_ DE<1>	$\begin{array}{ccc} 00 & PE=0dB, DE=0dB \\ 01 & PE=2.2dB, DE=0dB \\ 10 & PE=0dB, DE=-3.1dB \end{array}$		
4	R/W	0	CON_RX2_USB_GEN2_SW_PE_ DE<0>	11 PE=2.2dB, DE=-3.1dB		
3	R/W	0	CON_TX2_USB_GEN1_SW_ DE<1>			
2	R/W	0	CON_TX2_USB_GEN1_SW_ DE<0>	USB mode CON2: USB Gen1 De-emphasis setting USB_GEN1_SW_DE<1:0>		
1	R/W	0	CON_RX2_USB_GEN1_SW_ DE<1>	$\begin{array}{ccc} 00 & DE=0dB \\ 01 & DE=-3.5dB \\ 1 & DE=-6 \\ \end{array}$		
0	R/W	0	CON_RX2_USB_GEN1_SW_ DE<0>	$\Box IX \qquad DE = -6 dB$		





Byte 7 (Byte 7 (CON1 USB mode Pre-shot and De-emphasis setting)				
Bit	Туре	Power up condition	Purpose	Comment	
7	R/W	0	CON_TX1_USB_GEN2_SW_PE_ DE<1>	USB mode CON1:	
6	R/W	0	CON_TX1_USB_GEN2_SW_PE_ DE<0>	USB Gen2 Pre-shot and De-emphasis setting USB_GEN2_SW_PE_DE<1:0>	
5	R/W	0	CON_RX1_USB_GEN2_SW_PE_ DE<1>	$\begin{array}{ccc} 00 & PE=0 dB, DE=0 dB \\ 01 & PE=2.2 dB, DE=0 dB \\ 10 & PE=0 dB, DE=-3.1 dB \end{array}$	
4	R/W	0	CON_RX1_USB_GEN2_SW_PE_ DE<0>	11 PE=2.2dB, DE=-3.1dB	
3	R/W	0	CON_TX1_USB_GEN1_SW_ DE<1>		
2	R/W	0	CON_TX1_USB_GEN1_SW_ DE<0>	USB mode CON1: USB Gen1 De-emphasis setting USB_GEN1_SW_DE<1:0>	
1	R/W	0	CON_RX1_USB_GEN1_SW_ DE<1>	$\begin{array}{ccc} 00 & DE=0dB \\ 01 & DE=-3.5dB \\ 1 & DE=-6dB \end{array}$	
0	R/W	0	CON_RX1_USB_GEN1_SW_ DE<0>	TX DE = -6dB	
Byte 8-	15 Reserve	d RW: 0x00h			
Byte 16	-17 Reserv	ed RO: 0x02h			
Byte 18	(Monitor	the channel feature	setting)		
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	1	CON_TX2_AP2CON_SEL	_	
6	RO	1	CON_RX2_AP2CON_SEL	Signal flow of channel	
5	RO	1	CON_TX1_AP2CON_SEL	1: Signal is from AP side to CON side	
4	RO	1	CON_RX1_AP2CON_SEL		
3	RO	0	Reserved		
2	RO	0	Reserved		
1	RO	0	USB_DUAL_LANE_FEATURE_EN	Enable/Disable the USB Gen2x2 feature 0 – USB Gen2x2 feature is disabled 1 – USB Gen2x2 feature is enabled	
0	RO	0	Reserved		
Byte 19	-23 Reserv	ed R/W: 0x00h			
Byte 24 Reserved R/W: 0x20h					
Byte 25-27 Reserved R/W: 0x00h					
	Read Only Register Section				
Byte 28	-30 Reserv	ed RO: 0x00h			
Byte 31-32 Reserved RO: 0xAAh and 0x08h					





Byte 33	Byte 33 (Common Monitor for CON2 Setting)				
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	Reserved		
6	RO	0	Reserved		
5	RO	0	Reserved		
4	RO	0	Reserved		
3	RO	0	CON2_USB_DUALLANE_MON	Monitor the CON2 USB LBPM dual lane decoded value 0 – Duallane service is not detected. 1 – Duallane service is detected	
2	RO	0	CON2_USB_DATARATE_MON	Monitor the CON2 USB LBPM datarate decoded value 0 – USB Gen1 1 – USB Gen2	
1	RO	0	CON2_WARMRESET_MON	Monitor the CON2 USB LBPM warmreset decoded value 0 – WarmReset pattern is not detected 1 – WarmReset pattern is detected	
0	RO	0	CON2_DSM_TIMEOUT_MON	Monitor the CON2 USB 328ms electrical IDLE Timeout 0 – The electrical idle is shorter than 328ms typ 1 – The electrical idle is longer than 328ms typ	
Byte 34	Reserved	RO: 0x08h		·	
Byte 35	(Common	Monitor for CON1	Setting)		
Bit	Туре	Power up condition	Purpose	Comment	
7	R/W	0	Reserved		
6	R/W	0	Reserved		
5	R/W	0	Reserved		
4	R/W	0	Reserved		
3	R/W	0	CON1_USB_DUALLANE_MON	Monitor the CON2 USB LBPM dual lane decoded value 0 – Duallane service is not detected 1 – Duallane service is detected	
2	R/W	0	CON1_USB_DATARATE_MON	Monitor the CON2 USB LBPM datarate decoded value 0 – USB Gen1 1 – USB Gen2	
1	R/W	0	CON1_WARMRESET_MON	Monitor the CON2 USB LBPM warmreset decoded value 0 – WarmReset pattern is not detected 1 – WarmReset pattern is detected	
0	R/W	0	CON1_DSM_TO_MON	Monitor the CON2 USB 328ms electrical IDLE Timeout 0 – The electrical idle is shorter than 328ms typ. 1 – The electrical idle is longer than 328ms typ.	
				0 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1	





Byte 37	Rute 37 (Manitar far CAN-TX2 CDR lack status)					
Dyte 57	Tuno	Bower un condition	Purposo	Comment		
БЦ	Туре	rower up condition	rurpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	CON_TX2_CDR_LOCKED	CON_TX2 CDR_LOCKED Monitor		
4	RO	0	CON_TX2_PLL_LOCKED	CON_TX2 PLL LOCKED Monitor		
3	RO	0	Reserved			
2	RO	0	Reserved	December 1		
1	RO	0	Reserved	Reserved		
0	RO	0	Reserved			
Byte 38	(Monitor	for CON_TX2 RX A	Auto CTLE Setting)			
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	CON_TX2_CTLE_CAL_DONE	CON_TX2 CTLE AUTO_CAL CAL_DONE monitor		
4	RO	0	Reserved			
3	RO	0	CON_TX2_CTLE_CODE<3>	CON TX2 CTLF CODE<3:0> monitor		
2	RO	0	CON_TX2_CTLE_CODE<2>	CTLE_CODE<3:0>		
1	RO	0	CON_TX2_CTLE_CODE<1>	0000 Min CTLE setting		
0	RO	0	CON_TX2_CTLE_CODE<0>	IIII Max CILE setting		
Byte 39	Reserved	RO: 0x00h				
Byte 40	(Monitor	Channel PD Status	and CON_TX2 LFPS_Decoder	Setting)		
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	1	CON_TX2_PD#	CON_TX2 PD# status monitor		
5	RO	0	Reserved			
4	RO	0	CON_TX2 USB_DUAL_LANE	CON_TX2 LBPM USB Duallane decoded value		
3	RO	0	CON_TX2_USB_DATARATE	CON_TX2 LBPM USB Datarate decoded value		
2	RO	0	CON_TX2_USB_WARMRESET	CON_TX2 LBPM USB WarmReset decoded value		
1	RO	0	Reserved			
0	RO	0	Reserved			
Byte 41	Byte 41 Reserved RO: 0x00h					





Byte 42	Byte 42 (Monitor for CON_TX2 operating mode Setting)					
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	CON_TX2_HS_IDLE	CON_TX2 idle status of the HS_IDET 0 – Signal is detected 1 – No input signal is detected		
6	RO	0	CON_TX2_LFPS_IDLE	CON_TX2 idle status of the LFPS_IDET 0 – LFPS Signal is detected 1 – No input signal is detected		
5	RO	0	CON_TX2 DET_5Gbps	CON_TX2 input signal type 0 – LFPS signal 1 – 5Gbps/10Gbps high speed signal		
4	RO	0	CON_TX2_HS_OP_MODE<4>			
3	RO	0	CON_TX2_HS_OP_MODE<3>			
2	RO	0	CON_TX2_HS_OP_MODE<2>	CON_TX2 channel operating mode		
1	RO	0	CON_TX2_HS_OP_MODE<1>			
0	RO	0	CON_TX2_HS_OP_MODE<0>			
Byte 43	(Monitor	for CON_TX2 RX s	ignal status and USB Complianc	e test mode status)		
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	CON_TX2_RX50	CON_TX2 50 Ω load status 0 – No 50 Ω load is detected 1 – 50 Ω load is detected		
6	RO	0	Reserved			
5	RO	0	CON_TX2_COMP_MODE_EN	CON_TX2 USB compliance test mode status. 0 - The lane is in the normal USB mode. 1 - The lane is in the Compliance test mode.		
4	RO	0	CON_TX2_COMP_MODE<4>			
3	RO	0	CON_TX2_COMP_MODE<3>	CON_TX2 compliance test mode state monitor \cdot CON_TX2 COMP_MODE<4.0> register is cycling be-		
2	RO	0	CON_TX2_COMP_MODE<2>	tween 0x0d and 0x16d.		
1	RO	0	CON_TX2_COMP_MODE<1>	• The register value is advanced by the Ping .LFPS pulse of the adjacent channels.		
0	RO	0	CON_TX2_COMP_MODE<0>			





Byte 44 (Monitor for CON_TX2 TX SW & DE & PE Setting)						
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	Reserved			
4	RO	0	CON_TX2_TX_SW_DE_PE_ CTRL<4>			
3	RO	0	CON_TX2_TX_SW_DE_PE_ CTRL<3>			
2	RO	0	CON_TX2_TX_SW_DE_PE_ CTRL<2>	CON_TX2 SW&DE&PE setting monitor		
1	RO	0	CON_TX2_TX_SW_DE_PE_ CTRL<1>			
0	RO	0	CON_TX2_TX_SW_DE_PE_ CTRL<0>			
Byte 45	Byte 45 Reserved RO: 0x00h					
Byte 46	(Monitor	for CON_RX2 CDR	lock status)			
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	CON_RX2_CDR_LOCKED	CON_RX2 CDR_LOCKED Monitor		
4	RO	0	CON_RX2_PLL_LOCKED	CON_RX2 PLL LOCKED Monitor		
3	RO	0	Reserved			
2	RO	0	Reserved			
1	RO	0	Reserved			
0	RO	0	Reserved			
Byte 47	(Monitor	for CON_RX2 RX A	Auto CTLE Setting)			
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	CON_RX2_CTLE_CAL_DONE	CON_RX2 CTLE AUTO_CAL CAL_DONE monitor		
4	RO	0	Reserved			
3	RO	0	CON_RX2_CTLE_CODE<3>			
2	RO	0	CON_RX2_CTLE_CODE<2>	CON_KAZ CILE_CODE<3:0> monitor CTLE_CODE<3:0>		
1	RO	0	CON_RX2_CTLE_CODE<1>	0000 Min CTLE setting		
0	RO	0	CON_RX2_CTLE_CODE<0>			
Byte 48	Byte 48 Reserved RO: 0x00h					





Byte 49 (Monitor Channel PD Status and CON_RX2 LFPS_Decoder Setting)					
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	Reserved		
6	RO	1	CON_RX2_PD#	CON_RX2 PD# status monitor	
5	RO	0	Reserved		
4	RO	0	CON_RX2 USB_DUAL_LANE	CON_RX2 LBPM USB Duallane decoded value	
3	RO	0	CON_RX2_USB_DATARATE	CON_RX2 LBPM USB Datarate decoded value	
2	RO	0	CON_RX2_USB_WARMRESET	CON_RX2 LBPM USB WarmReset decoded value	
1	RO	0	Reserved		
0 RO 0 Reserved					
Byte 50	Reserved	RO: 0x00h			
Byte 51	(Monitor	for CON_RX2 oper	ating mode Setting)		
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	CON_RX2_HS_IDLE	CON_RX2 idle status of the HS_IDET 0 – Signal is detected 1 – No input signal is detected	
6	RO	0	CON_RX2_LFPS_IDLE	CON_RX2 idle status of the LFPS_IDET 0 – LFPS Signal is detected 1 – No input signal is detected	
5	RO	0	CON_RX2 DET_5Gbps	CON_RX2 input signal type 0 – LFPS signal 1 – 5Gbps/10Gbps high speed signal	
4	RO	0	CON_RX2_HS_OP_MODE<4>		
3	RO	0	CON_RX2_HS_OP_MODE<3>		
2	RO	0	CON_RX2_HS_OP_MODE<2>	CON_RX2 channel operating mode	
1	RO	0	CON_RX2_HS_OP_MODE<1>		
0	RO	0	CON_RX2_HS_OP_MODE<0>		





Byte 52 (Monitor for CON_RX2 RX signal status and USB Compliance test mode status)								
Bit	Bit Type Power up condition Purpose Comment							
7	RO	0	CON_RX2_RX50	CON_RX2 50 Ω load status 0 – No 50 Ω load is detected 1 – 50 Ω load is detected				
6	RO	0	CON_RX2_LOW_VCM_SEL	CON_RX2 channel status 0 – The channel is in DSM/UPM mode 1 – The Channel is in SM/AM mode				
5	RO	0	CON_RX2_COMP_MODE_EN	CON_RX2 USB compliance test mode status.0 - The lane is in the normal USB mode.1 - The lane is in the Compliance test mode.				
4	RO	0	CON_RX2_COMP_MODE<4>					
3	RO	0	CON_RX2_COMP_MODE<3>	CON_RX2 compliance test mode state monitor • CON_RX2 COMP_MODE<4:0> register is cycling be-				
2	RO	0	CON_RX2_COMP_MODE<2>	tween 0x0d and 0x16d.				
1	RO	0	CON_RX2_COMP_MODE<1>	• The register value is advanced by the Ping. LFPS pluse of the adjacent channels.				
0	RO	0	CON_RX2_COMP_MODE<0>					
Byte 53	(Monitor	for CON_RX2 TX S	SW & DE & PE Setting)					
Bit	Туре	Power up condition	Purpose	Comment				
7	RO	0	Reserved					
6	RO	0	Reserved					
5	RO	0	Reserved					
4	RO	0	CON_RX2_TX_SW_DE_PE_ CTRL<4>					
3	RO	0	CON_RX2_TX_SW_DE_PE_ CTRL<3>					
2	RO	0	CON_RX2_TX_SW_DE_PE_ CTRL<2>	CON_RX2 SW&DE&PE setting monitor				
1	RO	0	CON_RX2_TX_SW_DE_PE_ CTRL<1>					
0 RO		0	CON_RX2_TX_SW_DE_PE_ CTRL<0>					
Byte 54	Reserved	RO: 0x00h						





Byte 55	Byte 55 (Monitor for CON_TX1 CDR lock status)				
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	Reserved		
6	RO	0	Reserved		
5	RO	0	CON_TX1_CDR_LOCKED	CON_TX1 CDR_LOCKED Monitor	
4	RO	0	CON_TX1_PLL_LOCKED	CON_TX1 PLL LOCKED Monitor	
3	RO	0	Reserved		
2	RO	0	Reserved		
1	RO	0	Reserved		
0	RO	0	Reserved		
Byte 56	(Monitor	for CON_TX1 RX A	Auto CTLE Setting)		
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	Reserved		
6	RO	0	Reserved		
5	RO	0	CON_TX1_CTLE_CAL_DONE	CON_TX1 CTLE AUTO_CAL CAL_DONE monitor	
4	RO	0	Reserved		
3	RO	0	CON_TX1_CTLE_CODE<3>	CON TWI CTLE CODE (2.0) monitor	
2	RO	0	CON_TX1_CTLE_CODE<2>	CON_IXICILE_CODE<3:0> monitor CTLE_CODE<3:0>	
1	RO	0	CON_TX1_CTLE_CODE<1>	0000 Min CTLE setting	
0	RO	0	CON_TX1_CTLE_CODE<0>	1111 Max CILE setting	
Byte 57	Reserved	RO: 0x00h			
Byte 58	(Monitor	Channel PD Status	and CON_TX1 LFPS_Decoder S	Setting)	
Bit	Туре	Power up condition	Purpose	Comment	
7	RO	0	Reserved		
6	RO	1	CON_TX1_PD#	CON_TX1 PD# status monitor	
5	RO	0	Reserved		
4	RO	0	CON_TX1 USB_DUAL_LANE	CON_TX1 LBPM USB Duallane decoded value	
3	RO	0	CON_TX1_USB_DATARATE	CON_TX1 LBPM USB Datarate decoded value	
2	RO	0	CON_TX1_USB_WARMRESET	CON_TX1 LBPM USB WarmReset decoded value	
1	RO	0	Reserved		
0	RO	0	Reserved		
Byte 59	Reserved	RO: 0x00h		·	





Byte 60	Byte 60 (Monitor for CON_TX1 operating mode Setting)						
Bit	Туре	Type Power up condition Purpose Comment					
7	RO	0	CON_TX1_HS_IDLE	CON_TX1 idle status of the HS_IDET 0 – Signal is detected 1 – No input signal is detected			
6	RO	0	CON_TX1_LFPS_IDLE	CON_TX1 idle status of the LFPS_IDET 0 – LFPS Signal is detected 1 – No input signal is detected			
5	RO	0	CON_TX1 DET_5Gbps	CON_TX1 input signal type 0 – LFPS signal 1 – 5Gbps/10Gbps high speed signal			
4	RO	0	CON_TX1_HS_OP_MODE<4>				
3	RO	0	CON_TX1_HS_OP_MODE<3>				
2	RO	0	CON_TX1_HS_OP_MODE<2>	CON_TX1 channel operating mode			
1 RO		0	CON_TX1_HS_OP_MODE<1>				
0	RO	0	CON_TX1_HS_OP_MODE<0>				
Byte 61	(Monitor	for CON_TX1 RX s	ignal status and USB Complianc	e test mode status)			
Bit	Туре	Power up condition	Purpose	Comment			
7	RO	0	CON_TX1_RX50	CON_TX1 500hm load status 0 – No 500hm load is detected. 1 – 500hm load is detected			
6	RO	0	CON_TX1_LOW_VCM_SEL	CON_TX1 channel status 0 – The channel is in DSM/UPM mode 1 – The Channel is in SM/AM mode			
5	RO	0	CON_TX1_COMP_MODE_EN	CON_TX1 USB compliance test mode status. 0 - The lane is in the normal USB mode. 1 - The lane is in the Compliance test mode.			
4	RO	0	CON_TX1_COMP_MODE<4>				
3	RO	0	CON_TX1_COMP_MODE<3>	CON_TX1 compliance test mode state monitor • CON_TX1_COMP_MODE<4:0> register is cycling be-			
2	RO	0	CON_TX1_COMP_MODE<2>	tween 0x0d and 0x16d.			
1	RO	0	CON_TX1_COMP_MODE<1>	• The register value is advanced by the Ping. LFPS pulse of the adjacent channels.			
0	0 RO 0 CON_TX1_COMP_MODE<0> t		CON_TX1_COMP_MODE<0>				





Byte 62	Byte 62 (Monitor for CON_TX1 TX SW & DE & PE Setting)						
Bit	Туре	Power up condition	Purpose	Comment			
7	RO	0	Reserved				
6	RO	0	Reserved				
5	RO	0	Reserved				
4	RO	0	CON_TX1_TX_SW_DE_PE_ CTRL<4>				
3	RO	0	CON_TX1_TX_SW_DE_PE_ CTRL<3>				
2	RO	0	CON_TX1_TX_SW_DE_PE_ CTRL<2>	CON_TX1 SW&DE&PE setting monitor			
1	1 RO 0		CON_TX1_TX_SW_DE_PE_ CTRL<1>				
0	RO	0	CON_TX1_TX_SW_DE_PE_ CTRL<0>				
Byte 63	Byte 63 Reserved RO: 0x00h						
Byte 64 (Monitor for CON_RX1 CDR lock status)							
Bit	Туре	Power up condition	Purpose	Comment			
7	RO	0	Reserved				
6	RO	0	Reserved				
5	RO	0	CON_RX1_CDR_LOCKED	CON_RX1 CDR_LOCKED Monitor			
4	RO	0	CON_RX1_PLL_LOCKED	CON_RX1 PLL LOCKED Monitor			
3	RO	0	Reserved				
2	RO	0	Reserved				
1	RO	0	Reserved				
0	RO	0	Reserved				
Byte 65	(Monitor	for CON_RX1 RX A	Auto CTLE Setting)				
Bit	Туре	Power up condition	Purpose	Comment			
7	RO	0	Reserved				
6	RO	0	Reserved				
5	RO	0	CON_RX1_CTLE_CAL_DONE	CON_RX1 CTLE AUTO_CAL CAL_DONE monitor			
4	RO	0	Reserved				
3	RO	0	CON_RX1_CTLE_CODE<3>	CON BY1 CTLE CODE 2:05 monitor			
2	RO	0	CON_RX1_CTLE_CODE<2>	CTLE_CODE<3:0>			
1	RO	0	CON_RX1_CTLE_CODE<1>	0000 Min CTLE setting			
0	RO	0	CON_RX1_CTLE_CODE<0>				
Byte 66	Reserved	RO: 0x00h					





Byte 67 (Monitor Channel PD Status and CON_RX1 LFPS_Decoder Setting)						
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved	Reserved		
6	RO	1	CON_RX1_PD#	CON_RX1 PD# status monitor		
5	RO	0	Reserved			
4	RO	0	CON_RX1 USB_DUAL_LANE	CON_RX1 LBPM USB Duallane decoded value		
3	RO	0	CON_RX1_USB_DATARATE	CON_RX1 LBPM USB Datarate decoded value		
2	RO	0	CON_RX1_USB_WARMRESET	CON_RX1 LBPM USB WarmReset decoded value		
1	RO	0	Reserved			
0 RO 0 Reserved						
Byte 68	Byte 68 Reserved RO: 0x00h					
Byte 69	(Monitor	for CON_RX1 oper	ating mode Setting)			
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	CON_RX1_HS_IDLE	CON_RX1 idle status of the HS_IDET 0 – Signal is detected 1 – No input signal is detected		
6	RO	0	CON_RX1_LFPS_IDLE	CON_RX1 idle status of the LFPS_IDET 0 – LFPS Signal is detected 1 – No input signal is detected		
5	RO	0	CON_RX1 DET_5Gbps	CON_RX1 input signal type 0 – LFPS signal 1 – 5Gbps/10Gbps high speed signal		
4	RO	0	CON_RX1_HS_OP_MODE<4>			
3	RO	0	CON_RX1_HS_OP_MODE<3>			
2	RO	0	CON_RX1_HS_OP_MODE<2>	CON_RX1 channel operating mode		
1	RO	0	CON_RX1_HS_OP_MODE<1>			
0	RO	0	CON_RX1_HS_OP_MODE<0>			





Byte 70	Byte 70 (Monitor for CON_RX1 RX signal status and USB Compliance test mode status)					
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	CON_RX1_RX50	CON_RX1 500hm load status 0 – No 500hm load is detected 1 – 500hm load is detected		
6	RO	0	CON_RX1_LOW_VCM_SEL	CON_RX1 channel status 0 – The channel is in DSM/UPM mode 1 – The Channel is in SM/AM mode		
5	RO	0	CON_RX1_COMP_MODE_EN	CON_RX1 USB compliance test mode status.0 - The lane is in the normal USB mode.1 - The lane is in the Compliance test mode.		
4	RO	0	CON_RX1_COMP_MODE<4>			
3 RO 2 RO 1 RO		0	CON_RX1_COMP_MODE<3>	CON_RX1 compliance test mode state monitor		
		0	CON_RX1_COMP_MODE<2>	tween 0x0d and 0x16d.		
		0	CON_RX1_COMP_MODE<1>	• The register value is advanced by the Ping. LFPS pulse of the adjacent channels.		
0	RO	0	CON_RX1_COMP_MODE<0>			
Byte 71	(Monitor	for CON_RX1 TX S	SW & DE & PE Setting)			
Bit	Туре	Power up condition	Purpose	Comment		
7	RO	0	Reserved			
6	RO	0	Reserved			
5	RO	0	Reserved			
4	RO	0	CON_RX1_TX_SW_DE_PE_ CTRL<4>			
3	RO	0	CON_RX1_TX_SW_DE_PE_ CTRL<3>			
2	RO	0	CON_RX1_TX_SW_DE_PE_ CTRL<2>	CON_RX1 SW&DE&PE setting monitor		
1	RO	0	CON_RX1_TX_SW_DE_PE_ CTRL<1>			
0 RO		0	CON_RX1_TX_SW_DE_PE_ CTRL<0>			
Byte 72	-Byte 95 R	eserved RO register	rs			
Byte 96	-Byte 127	Reserved RW regist	er			





4.5.1 Each Lane Configuration Setting

Below is showing the configuration of each lane after decoded from the I2C OP_MODE<3:0>

OP_MODE<3:0>	CON_TX2	CON_RX2	CON_TX1	CON_RX1	Support Gen2x2	Mode
0000	Х	Х	Х	X	Х	Safe Sate
0001	Х	Х	X	X	Х	Safe Sate
0100	Х	Х	AP_RX1	AP_TX1	Х	1 lane USB3.x (AP1 Active)
0101	AP_RX2	AP_TX2	X	X	Х	1 lane USB3.x (AP2 Active) flipped
1110	AP_RX2	AP_TX2	AP_RX1	AP_TX1	Yes	2 lane USB3.x (Supports Type-C Gen2x2
1111	AP_RX2	AP_TX2	AP_RX1	AP_TX1	No	2 lane USB3.x (Supports two Type-A USB lane

Table 4-1. The Channel Configuration Against the OP MODE<3:0>





5. Electrical Specification

5.1 Absolute Maximum Ratings

Supply Voltage0.3V to 2.0V	Note:
I/O Voltage (AP_RX, AP_TX, CON_RX, CON_TX, CAP_CON1, CAP_CON2)0.3V to 1.15V	MUN
I/O Voltage (SDA, SCL)0.3V to 3.8V	to th
I/O Voltage (EN, A0)0.3V to 2.0V	funct
Storage Temperature65°C to +150°C	other
Max junction temperature	opera
ESD HBM ±2kV	rating
ESD CDM	inope
	and n

Stresses greater than those listed under MAXI-MUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to beyond the absolute maximum rating conditions for extended periods may affect inoperability and degradation of device reliability and performance.

5.2 Recommended Operating Conditions

Over Operating Temperature Range (unless otherwise noted)

Symbol	Parameter		Min.	Тур.	Max	Units
V _{DD}	VDD Supply Voltage	VDD Supply Voltage		1.8	1.89	V
V _{DD_I2C}	VDD I2C Supply Voltage				3.6	V
V _{NOISE}	Supply Noise up to 50 MHz ⁽¹⁾			100		mVpp
T _A	A web is not To many sources	Commercial range	0		70	
	Industrial range	-40		85		
CAP_CON1					15	Г
CAP_CON2	External VDD1V_CON1/2 decoupling capacitors with max $\pm 20\%$ tolerance				15	nF

Notes:

(1) Allowed supply noise (mVpp sign wave) under typical condition

(2) Industrial temperature -40 to +85 °C can be guaranteed by design. Commercial temperature 0 to +70 °C is supported by the production-tested.

5.3 Power Consumption

Symbol	Parameter	Condition		Min.	Тур.	Max	Units
т			Gen2x1		180	210	mA
IU0_USB	Current in USB U0 mode	EN=1, USB Gen2, U0 mode	Gen2x2		360	420	
т		EN=1, USB U1 mode,	1 Lane		16	20	mA
I _{U1_USB}	Current in USB U1 mode	VDD=1.8V	2 Lane		32	40	
T	Current in USB U2/U3 modes	EN=1, USB U2/U3 mode, VDD= 1.8V	1 Lane		800	1800	μΑ
IU2/U3_USB			2 Lane		900	2000	
I _{RXDET_USB}	Current in USB RXDET mode	EN=1, USB RXDET mode.	1 Lane		735	1700	- μΑ
		VDD =1.8V	2 Lane		800	1900	

5.4 AC/DC Characteristics

Symbol	Parameter	Condition	Min.	Тур.	Max	Units		
LVCMOS I/O DC Specifications								
V _{IH}	DC input logic High		V _{DD} *0.65			V		





Symbol	Parameter	Condition	Min.	Тур.	Max	Units
V _{IL}	DC input logic Low				V_{DD} *0.35	V
I _{IH}	Input High current				25	uA
I _{IL}	Input Low current		-25			uA

5.5 USB Electrical Specification

Symbol	Parameter	Condition	Min.	Тур.	Max	Units
USB Differential I	input					
		Gen 2 10Gbps	99.97 100.17		100.03 100.23	ps
UI	Unit Interval	Gen 1 5Gbps	199.94 200.34		200.06 200.46	ps
CRXPARA- SITIC	The parasitic capacitor for RX				1.0	pF
RRX-DIFF-DC	DC Differential Input Impedance		72		120	Ω
RRX-SINGLE_ DC	DC single ended input impedance	DC impedance limits are need to guarantee RxDet. Measured with respect to GND over a voltage of 500mV max	18		30	Ω
ZRX-HIZ-DC- PD	DC input CM input impedance for V>0 during reset or power down	(Vcm=0 to 500mV)	25			kΩ
CAC_COU- PLING	AC coupling capacitance		75		265	nF
VRX-CM-DC_ CONN	Instantaneous DC common mode voltage coupled from the far-end Tx	Apply to all link states and during power-on, and power-off. (min1, max) is observed at receiver side of the connector when Rx termination is equivalent of $200K\Omega$, and (min2, max) when Rx termination is 50Ω .	-0.5 (min1) -0.3 (min2)		1.0	V
VRX-CM-AC-P	Common mode peak voltage	AC up to 5GHz			150	mVpeak
VRX-CM-DC- Active-Idle-Del- ta-P	Common mode peak voltage ⁽¹⁾	Between U0 and U1. AC up to 5GHz			200	mVpeak
USB Differential (Dutput			-		
		Gen 2 10Gbps	99.97 100.17		100.03 100.23	ps
UI		Gen 1 5Gbps	199.94 200.34		200.06 200.46	ps
VTX-DIFF-PP	Output differential p-p voltage swing	2* VTX-D+-VTX-D-	0.8		1.2	Vppd
RTX-DIFF-DC	DC Differential TX Impedance		72		120	Ω





Symbol	Parameter	Condition	Min.	Тур.	Max	Units
VTX-RCV-DET	The amount of voltage change allowed during RxDet				600	mV
Cac_coupling	AC coupling capacitance		75		265	nF
T _{TJ_TP3_10Gbps}	Total Jitter with pattern CP9, 10Gbps	Measure over 1E6 consec- utive UI and extrapolated			0.671	UI
T _{TJ_TP3_5Gbps}	Total Jitter with pattern CP0, 5Gbps	TP3 with Compliance RX EQ function.			0.66	UI
T _{RJ_TP3_10Gbps}	Random jitter with pattern CP10, 5GHz	Measure over 1E6 consec- utive UI and extrapolated to BER=1E-12. The RJ			0.53	UI
TRJ_TP3_5Gbps	Random Jitter with pattern CP1, 2.5GHz	RMS random jitter for BER=1E-12. Measure at TP3.			0.43	UI
Veyeh_TP3_10Gbps	Eye height for the CP9, 10Gbps	Measure over 1E6 consec- utive UI and extrapolated to BER=1E-12. Measure at TP3 with Compliance RX	70		1200	mVppd
Veyeh_TP3_5Gbps	Eye height for the CP9, 5Gbps	EQ. Eye height measures the min opening over the range from the center of the eye +/- 0.05UI.	100		1200	mVppd
CTXPARA- SITIC	The parasitic capacitor for TX				1.1	pF
RTX-DC-CM	Common mode DC output Impedance		18		30	Ω
VTX-DC-CM	The instantaneous allowed DC common mode voltage at the connector side of the AC coupling capacitors	Instantaneous DC+AC voltages at the connector side of the AC coupling capacitors. min1 is measured with a 200K Ω receiver load, and min2 is measured with a 50 Ω receiver load.	-0.5V (min1) -0.3V (min2)		1.0	V
VTx-CM-IDLE- DELTA	Transmitter idle common-mode voltage change	The maximum allowed instantaneous com- mon-mode voltage at TP2 while the transmitter is in U2 or U3 and not actively transmitting LFPS. Note that this is an absolute voltage spec referenced to the receive-side termina- tion ground but serves the purpose of limiting the magnitude and/or slew rate of Tx common mode changes.	-300		600	mV
VTX-C	Common-Mode Voltage	VTX-D++VTX-D-//2	0		1.15	V





Symbol	Parameter	Condition	Min.	Тур.	Max	Units
VTX-CM-AC- PP-Active	Active mode TX AC common mode voltage	VTX-D++VTX-D- for both time and amplitude			100	mVpp
VTX-CM- DC-Ac-tive_ Idle-Delta	Common mode delta voltage Avguo(V- TEX-D+ + VTX-D-)/2-Avgu1(VTX-D+ + VTX-D-)/2	Between U0 to U1			200	mVpeak
VTX-Idle-Diff- AC-pp	Idle mode AC common mode delta volt- age VTX-D+-VTX-D-	Between Tx+ and Tx- in idle mode. Use the HPF to remove DC components. =1/LPF. No AC and DC signals are applied to Rx terminals.			10	mVppd
VTX-Idle-Diff- DC	Idle mode DC common mode delta volt- age VTX-D+-VTX-D-	Between Tx+ and Tx- in idle mode. Use the LPF to remove DC components. =1/HPF. No AC and DC signals are applied to Rx terminals.			10	mV
Signal and Freque	ency Detectors					
VTH_UPM	Unplug mode detector threshold	Threshold of LFPS when the input impedance of the retimer is $75k\Omega$ to GND only. Used in the unplug mode.	200		600	mVppd
VTH_DSM	Deep slumber mode detector threshold	LFPS signal threshold in Deep slumber mode	200		600	mVppd
VTH_AM	Active mode detector threshold	Signal threshold in Active and slumber mode	50		100	mVppd
FTH	LFPS frequency detector	Detect the frequency of the input CLK pattern	100		400	MHz
TON_UPM	Turn on of unplug mode				3	ms
TON-DSM	Turn on of deep slumber mode	TX pin to RX pin latency when input signal is I FPS			5	us
TON_SM	Turn on of slumber mode				20	ns



1) Trace card between before DUT is designed to emulate FR4 trace loss.

2) All jitter is measured at BER=1E-9/BER=1E-12 for the USB applications respectively.

3) Trace card after the DUT is designed to emulate the Compliance Cable Model.

4) VDD = 1.8V, $RT = 50\Omega$

Figure 5-1 AC Electrical Parameter Test Setup











Figure 5-3 Definition of Differential voltage (VDIFF) and Differential Voltage Peak to peak (VDIFFPP)

Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
V _{IL}	DC input logic LOW		-0.5		0.4	V
V _{IH}	DC input logic HIGH		1.2		V _{DD}	V
V _{OL1}	DC output logic LOW voltage	(open-drain or open-collec- tor) at 3 mA sink current;	0		0.4	V
-	LOW/ Israel automation	$V_{OL} = 0.4 V$	20			mA
IOL	LOW-level output current	$V_{OL} = 0.6V$	6			mA
Ii	Input current each I/O pin		-10		10	uA
CI	Capacitance for each I/O pin				10	pF
f _{SCL}	Bus Operation Frequency				1000	KHz
t _{BUF}	Bus Free Time Between Stop and Start condition		1.3			us

5.6 I2C Interface Electrical Specification





Symbol	Parameter	Conditions	Min.	Тур.	Max	Units
t _{HD:STA}	Hold time after (Repeated) Start con- dition. After this period, the first clock is generated.	At Ipull-up, Max	0.6			us
t _{SU:STA}	Repeated start condition setup time		0.26			us
t _{SU:STO}	Stop condition setup time		0.26			us
t _{HD:DAT}	Data hold time		0			ns
t _{SU:DAT}	Data setup time		50			ns
t _{LOW}	Clock Low period		0.5			us
t _{HIGH}	Clock High period		0.26		50	us
t _F	Clock/Data fall time				120	ns
t _R	Clock/Data rise time				120	ns

Notes:

(1) Recommended value.

(2) Recommended maximum capacitance load per bus segment is 400pF.

(3) Compliant to I2C physical layer specification.

(4) VIL = 0.4V and VIH = 1.2V because the silicon needs to support both SCL/SDA with 1.8V/3.3V signaling level.



Figure 5-4 Definition of Timing on the I2C-Bus





Application 6.

Note: Information in the following applications sections is not part of the component specification, and does not warrant its accuracy or completeness. Customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

6.1 PI2EQX22024 Reference Schematics



Figure 6-1 PI2EQX22024 Reference Schematic





6.2 PCB Layout Guideline

6.2.1 General Power and Ground Guideline

To provide a clean power supply for Pericom high-speed device, few recommendations are listed below:

- Power (VDD) and ground (GND) pins should be connected to corresponding power planes of the printed circuit board directly without passing through any resistor.
- The thickness of the PCB dielectric layer should be minimized such that the VDD and GND planes create low inductance paths.
- One low-ESR 0.1uF decoupling capacitor should be mounted at each VDD pin or should supply bypassing for at most two VDD pins. Capacitors of smaller body size, i.e. 0402 package, is more preferable as the insertion loss is lower. The capacitor should be placed next to the VDD pin.
- One capacitor with capacitance in the range of 4.7uF to 10uF should be incorporated in the power supply decoupling design as well. • It can be either tantalum or an ultra-low ESR ceramic.
- A ferrite bead for isolating the power supply for Diodes high-speed device from the power supplies for other parts on the printed circuit board should be implemented.
- Several thermal ground vias must be required on the thermal pad. 25-mil or less pad size and 14-mil or less finished hole are rec-• ommended.



Figure 6-2 Decoupling Capacitor Placement Diagram





6.2.2 High-speed Signal Routing Guideline

Well-designed layout is essential to prevent signal reflection:

- For 90Ω differential impedance, width-spacing-width micro-strip of 6-7-6 mils is recommended; for 100Ω differential impedance, • width-spacing-width micro-strip of 5-7-5 mils is recommended.
- Differential impedance tolerance is targeted at $\pm 15\%$. .

	Single-ended mode:
Trace width: W= 6.0 🔿 mils	Characteristic Microstrip Stripline
Trace thickness: t = 1.9 🔿 mils (1.39 oz)	impedance: $Z_{0=} 50.7 $ 32.9 Ω
Trace spacing: S= 7.0 🗲 mils	Capacitance: Co= 2.70 6.30 pf/in
N: 1 · · · · · · · · · · · · · · · · · ·	Delay: Tpd= 137.1 171.6 ps/in
Dielectric (layer) thickness: h= 7.7 v mils (b=10.7 mils)	Speed: v= 185.4 148.2 mm/ns
Dielectric (layer) asymmetry: 50 🐨 % (h1=4.4, h2=4.4)	
Relative dielectric constant: 🕿 ^{4,} 호	Differential mode:
	Differential
PCB edge view	
$\begin{array}{c} \downarrow & \longleftarrow & \downarrow h^2 \\ \uparrow & \uparrow h \\ \hline & h \\ \end{array} \qquad \qquad$	2. Stripline Zo formula accurate if (W/b)<0.35 3. Stripline Zo formula accurate if (b/t)>4
Trace and board parameters:	Single-ended mode:
Trace width: W= 5.0 🜩 mils	Characteristic <u>Microstrip</u> Stripline
Trace thickness: t = 1.9 🔿 mils (1.39 oz)	impedance: $Z_{0=}$ 55.4 36.7 Ω
Trace spacing: S= 7.0 🜩 mils	Capacitance: Co= 2.47 5.54 pf/in
Trace spacing: S= 7.0 rmls	Capacitance: Co= 2.47 5.54 pf/in Delay: Tpd= 137.1 171.6 ps/in
Trace spacing: S = 7.0 mils Dielectric (layer) thickness: h= 4.4 mils (b=10.7 mils)	Capacitance: Co= 2.47 5.54 pf/in Delay: Tpd= 137.1 171.6 ps/in Speed: v= 185.4 148.2 mm/ns
Trace spacing: S = 7.0 mils Dielectric (layer) thickness: h= 4.4 mils (b=10.7 mils) Dielectric (layer) asymmetry: 50 30 % (h1=4.4, h2=4.4)	Capacitance: Co= 2.47 5.54 pf/in Delay: Tpd= 137.1 171.6 ps/in Speed: v= 185.4 148.2 mm/ns
Trace spacing: $S = 7.0$ milsDielectric (layer) thickness: $h = 4.4$ \clubsuit Dielectric (layer) asymmetry: 50 \clubsuit Relative dielectric constant: \approx 4.1	Capacitance: Co= 2.47 5.54 pf/in Delay: Tpd= 137.1 171.6 ps/in Speed: v= 185.4 148.2 mm/ns Differential mode:
Trace spacing: S = 7.0 ◆ mils Dielectric (layer) thickness: h= 4.4 ◆ mils (b=10.7 mils) Dielectric (layer) asymmetry: 50 ◆ % (h1=4.4, h2=4.4) Relative dielectric constant: æ 4.1 ◆	$\begin{array}{c c} Capacitance: Co= \hline 2.47 & 5.54 & pf/in \\ Delay: Tpd= \hline 137.1 & 171.6 & ps/in \\ Speed: v= \hline 185.4 & 148.2 & mm/ns \\ \hline Differential mode: \\ \hline Differential impedance: Zo= \hline 99.3 & 59.5 & \Omega \\ \hline \end{array}$

Figure 6-3 Trace Width and Clearance of Micro-strip and Strip-line

For micro-strip, using 1/2oz Cu is fine. For strip-line in 6+ PCB layers, 1oz Cu is more preferable. •











Figure 6-5 6-Layer PCB Stack-up Example

Ground referencing is highly recommended. If unavoidable, stitching capacitors of 0.1uF should be placed when reference plane . is changed.







Figure 6-6 Stitching Capacitor Placement

- To keep the reference unchanged, stitching vias must be used when changing layers.
- Differential pair should maintain symmetrical routing whenever possible. The intra-pair skew of micro-strip should be less than 5 mils.



Figure 6-7 Layout Guidance of Matched Differential Pair

- Wider trace width of each differential pair is recommended in order to minimize the loss, especially for long routing. More consistent PCB impedance can be achieved by a PCB vendor if trace is wider.
- Differential signals should be routed away from noise sources and other switching signals on the printed circuit board.
- To minimize signal loss and jitter, tight bend is not recommended. All angles α should be at least 135 degrees. The inner air gap A should be at least 4 times the spacing between the Trace and Reference plane.



Figure 6-8 Layout Guidance of Bends



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PI2EQX22024

Stub creation should be avoided when placing shunt components on a differential pair. •



Figure 6-9 Layout Guidance of Shunt Component

Placement of series components on a differential pair should be symmetrical.



Stitching vias or test points must be used sparingly and placed symmetrically on a differential pair. .







6.2.3 PCB Crosstalk Minimization recommendation

- Breakout Tx and Rx I/O on different PCB layers.
- Non-interleaved routing. Eliminates a key source of near end crosstalk.
- Inter-pair spacing between two differential micro-strip pairs should be at least 20 mils or 4 times the spacing between the Trace and Reference plane.
- Places requirements on Tx & Rx I/O placement as shown below.



Figure 6-12 Breakout Tx and Rx I/O on Different PCB Layers





7. Mechanical/Packaging Information

7.1 Mechanical Outline



Figure 7-1 Package Mechanical Dimension



YY: Date Code (Year) WW: Date Code (Workweek) 1st X: Assembly Code 2nd X: Fab Code Bar above 2nd "X" means Cu wire

Figure 7-2 Part Marking Information





7.2 Tape & Reel Materials and Design

Carrier Tape

The Pocketed Carrier Tape is made of Conductive Polystyrene plus Carbon material (or equivalent). The surface resistivity is 106Ohm/ sq. maximum. Pocket tapes are designed so that the component remains in position for automatic handling after cover tape is removed. Each pocket has a hole in the center for automated sensing if the pocket is occupied or not, thus facilitating device removal. Sprocket holes along the edge of the center tape enable direct feeding into automated board assembly equipment. See Figures 7-3 and 7-4 for carrier tape dimensions.

Cover Tape

Cover tape is made of Anti-static Transparent Polyester film. The surface resistivity is 10⁷Ohm/Sq. Minimum to 10¹¹Ohm sq. maximum. The cover tape is heat-sealed to the edges of the carrier tape to encase the devices in the pockets. The force to peel back the cover tape from the carrier tape shall be a MEAN value of 20 to 80gm (2N to 0.8N).

Reel

The device loading orientation is in compliance with EIA-481, current version (Figure 7-2). The loaded carrier tape is wound onto either a 13-inch reel, (Figure 7-4) or 7-inch reel. The reel is made of Antistatic High-Impact Polystyrene. The surface resistivity 10⁷Ohm/ sq. minimum to 10^{11} Ohm/sq. max.



Figure 7-3 Tape & Reel Label Information



Figure 7-4 Tape Leader and Trailer Pin 1 Orientations







Figure 7-5 Standard Embossed Carrier Tape Dimensions

Table 7-1.	Constant Dimensions
1abic / 1	Constant Dimensions

Tape Size	D	D ₁ (Min)	E ₁	P ₀	P ₂	R (See Note 2)	S ₁ (Min)	T (Max)	T ₁ (Max)		
8mm		1.0			20 + 0.05	25					
12mm					2.0 ± 0.05				0.6		
16mm	1.5 <u>+0.1</u>	1.5	175 ± 0.1	40 ± 0.1		30	0.0	0.6	0.1		
24mm	<u>-0.0</u>		1.75 ± 0.1	4.0 ± 0.1	2.0 ± 0.1			0.0	0.1		
32mm				50	N/A (See Note 2)						
44mm		2.0			2.0 ± 0.15	50	IN/A (See Note 5)				

Table 7-2. Variable Dimensions

Tape Size	P ₁	B ₁ (Max)	E ₂ (Min)	F	So	T ₂ (Max.)	W (Max)	$\mathbf{A}_{0}, \mathbf{B}_{0}, \mathbf{\&} \mathbf{K}_{0}$
8mm		4.35	6.25	3.5 ± 0.05		2.5	8.3	
12mm		8.2	10.25	5.5 ± 0.05	N/A (see	6.5	12.3	
16mm	Specific per package type.	12.1	14.25	7.5 ± 0.1	note 4)	8.0	16.3	Con Nata 1
24mm	Reel Packing Information)	20.1	22.25	11.5 ± 0.1		12.0	24.3	See Note 1
32mm		23.0	N/A	14.2 ± 0.1	28.4± 0.1	12.0	32.3	
44mm		35.0	N/A	20.2 ± 0.15	40.4 ± 0.1	16.0	44.3	

NOTES:

1. A0, B0, and K0 are determined by component size. The cavity must restrict lateral movement of component to 0.5mm maximum for 8mm and 12mm wide tape and to 1.0mm maximum for 16,24,32, and 44mm wide carrier. The maximum component rotation within the cavity must be limited to 200 maximum for 8 and 12 mm carrier tapes and 100 maximum for 16 through 44mm.

2. Tape and components will pass around reel with radius "R" without damage.

3. S1 does not apply to carrier width \geq 32mm because carrier has sprocket holes on both sides of carrier where Do \geq S1.

4. So does not exist for carrier ≤32mm because carrier does not have sprocket hole on both side of carrier.







Figure 7-6 Reel Dimensions

Table 7-3. Reel dimensions by Tape Size

Tape Size	А	N (Min) See Note A	\mathbf{W}_{1}	W ₂ (Max)	W ₃	B (Min)	С	D (Min)
8mm	178 ±2.0mm or	60 ±2.0mm or 100±2.0mm	8.4 +1.5/-0.0 mm	14.4 mm			13.0 +0.5/-0.2	
12mm	330±2.0mm		12.4 +2.0/-0.0 mm	18.4 mm				20.2mm
16mm			16.4 +2.0/-0.0 mm	22.4 mm	Shall Accommodate	1.5		
24mm	330 ±2.0mm 100 ±2.0mm	330 ±2.0mm 100 ±2.0mm 24.4 +2.0/-0.0 mm 30.4 mm Tape Width Without 330 ±2.0mm 100 ±2.0mm 32.4 +2.0/-0.0 mm 38.4 mm Interference	24.4 +2.0/-0.0 mm	30.4 mm	Interference	1.511111	mm	20.211111
32mm								
44mm			44.4 +2.0/-0.0 mm	50.4 mm				

NOTE:

A. If reel diameter A=178 ±2.0mm, then the corresponding hub diameter (N(min) will by 60 ±2.0mm. If reel diameter A=330±2.0mm, then the corresponding hub diameter (N(min)) will by 100±2.0mm.





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